	Se	arc	n	No	tes			
						-		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/683,665	ASTON ET AL.
Examiner	Art Unit
Tongoc Tran	2134

	SEAR	CHED	
			<u> </u>
Class	Subclass	Date	Examiner
726	22-25	12/7/2007	п
713	165-167	12/7/2007	TT
	,		

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
-					
	T				

SEARCH NOT (INCLUDING SEARCH	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR			
East	12/7/2007	П			
		,,			